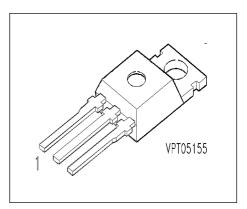
### **SIPMOS** ® Power Transistor

- P channel
- Enhancement mode
- Avalanche rated



Pin 1	Pin 2	Pin 3
G	D	S

Туре	V <sub>DS</sub>	I <sub>D</sub>	R <sub>DS(on)</sub>	Package	Ordering Code
BUZ 171	-50 V	-8 A	0.3 Ω	TO-220 AB	C67078-S1450-A2

#### **Maximum Ratings**

Parameter	Symbol	Values	Unit
Continuous drain current	I <sub>D</sub>		Α
$T_{\rm C}$ = 30 °C		-8	
Pulsed drain current	I <sub>Dpuls</sub>		
$T_{\rm C}$ = 25 °C		-32	
Avalanche energy, single pulse	E <sub>AS</sub>		mJ
$I_{\text{D}}$ = -8 A, $V_{\text{DD}}$ = -25 V, $R_{\text{GS}}$ = 25 $\Omega$			
$L = 1.1 \text{ mH}, T_j = 25 \text{ °C}$		70	
Gate source voltage	$V_{GS}$	± 20	V
Power dissipation	P <sub>tot</sub>		W
<i>T</i> <sub>C</sub> = 25 °C		40	
Operating temperature	$ T_{j} $	-55 <b>+</b> 150	°C
Storage temperature	$T_{stg}$	-55 <b>+</b> 150	
Thermal resistance, chip case	R <sub>thJC</sub>	≤ 3.1	K/W
Thermal resistance, chip to ambient	R <sub>thJA</sub>	≤ 75	
DIN humidity category, DIN 40 040		Е	
IEC climatic category, DIN IEC 68-1		55 / 150 / 56	



## **Electrical Characteristics**, at $T_j = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Static Characteristics					
Drain- source breakdown voltage	V <sub>(BR)DSS</sub>				V
$V_{\rm GS}$ = 0 V, $I_{\rm D}$ = -0.25 mA, $T_{\rm j}$ = 25 °C		-50	-	-	
Gate threshold voltage	V <sub>GS(th)</sub>				
$V_{\text{GS}}=V_{\text{DS}}$ , $I_{\text{D}}=1$ mA		-2.1	-3	-4	
Zero gate voltage drain current	I <sub>DSS</sub>				μA
$V_{\text{DS}}$ = -50 V, $V_{\text{GS}}$ = 0 V, $T_{\text{j}}$ = 25 °C		-	-0.1	-1	
$V_{\rm DS}$ = -50 V, $V_{\rm GS}$ = 0 V, $T_{\rm j}$ = 125 °C		-	-10	-100	
Gate-source leakage current	I <sub>GSS</sub>				nA
$V_{GS} = -20 \text{ V}, \ V_{DS} = 0 \text{ V}$		-	-10	-100	
Drain-Source on-resistance	R <sub>DS(on)</sub>				Ω
$V_{GS} = -10 \text{ V}, I_{D} = -5 \text{ A}$		-	0.25	0.3	



## **Electrical Characteristics**, at $T_j = 25$ °C, unless otherwise specified

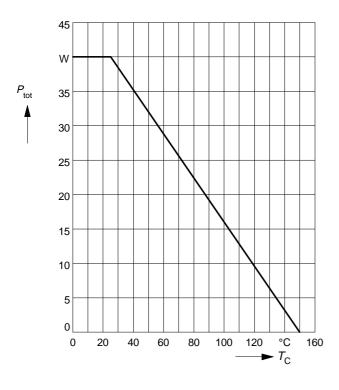
Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Dynamic Characteristics					
Transconductance	g <sub>fs</sub>				S
$V_{DS} \ge 2 * I_D * R_{DS(on)max}, I_D = -5 A$		1.5	2.3	-	
Input capacitance	$C_{iss}$				pF
$V_{GS} = 0 \text{ V}, \ V_{DS} = -25 \text{ V}, \ f = 1 \text{ MHz}$		-	750	1000	
Output capacitance	$C_{\text{oss}}$				
$V_{GS} = 0 \text{ V}, \ V_{DS} = -25 \text{ V}, \ f = 1 \text{ MHz}$		-	270	400	
Reverse transfer capacitance	$C_{rss}$				
$V_{GS} = 0 \text{ V}, \ V_{DS} = -25 \text{ V}, \ f = 1 \text{ MHz}$		-	120	180	
Turn-on delay time	$t_{d(on)}$				ns
$V_{\rm DD}$ = -30 V, $V_{\rm GS}$ = -10 V, $I_{\rm D}$ = -2.9 A					
$R_{\rm GS} = 50 \ \Omega$		-	20	30	
Rise time	$t_{r}$				
$V_{\rm DD}$ = -30 V, $V_{\rm GS}$ = -10 V, $I_{\rm D}$ = -2.9 A					
$R_{\rm GS} = 50 \ \Omega$		-	110	170	
Turn-off delay time	$t_{\rm d(off)}$				
$V_{\rm DD}$ = -30 V, $V_{\rm GS}$ = -10 V, $I_{\rm D}$ = -2.9 A					
$R_{\rm GS} = 50 \ \Omega$		-	70	90	
Fall time	<i>t</i> <sub>f</sub>				
$V_{\mathrm{DD}}$ = -30 V, $V_{\mathrm{GS}}$ = -10 V, $I_{\mathrm{D}}$ = -2.9 A					
$R_{\rm GS} = 50 \ \Omega$		-	100	140	

## **Electrical Characteristics**, at $T_j = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Reverse Diode					
Inverse diode continuous forward current	Is				Α
<i>T</i> <sub>C</sub> = 25 °C		-	-	-8	
Inverse diode direct current,pulsed	I <sub>SM</sub>				
<i>T</i> <sub>C</sub> = 25 °C		-	-	-32	
Inverse diode forward voltage	$V_{\mathrm{SD}}$				V
$V_{GS} = 0 \text{ V}, I_{F} = -16 \text{ A}$		-	-1.25	-1.7	
Reverse recovery time	$t_{rr}$				ns
$V_{R}$ = -30 V, $I_{F}=I_{S}$ , $dI_{F}/dt$ = 100 A/ $\mu$ s		-	90	-	
Reverse recovery charge	Q <sub>rr</sub>				μC
$V_{R}$ = -30 V, $I_{F}=I_{S_{1}} di_{F}/dt$ = 100 A/ $\mu$ s		-	0.23	-	

#### **Power dissipation**

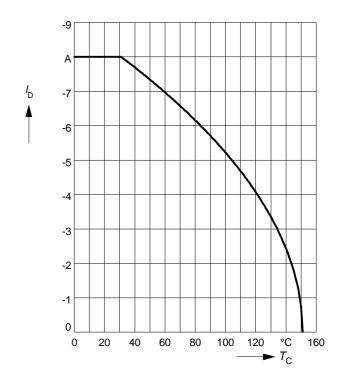
$$P_{\mathsf{tot}} = f(T_{\mathsf{C}})$$



#### **Drain current**

$$I_{\mathsf{D}} = f(T_{\mathsf{C}})$$

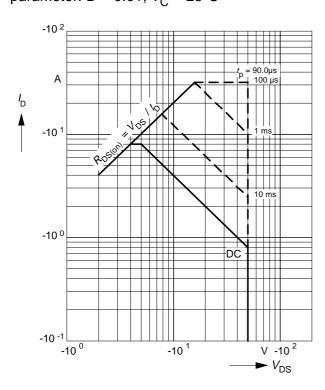
parameter:  $V_{GS} \ge -10 \text{ V}$ 



#### Safe operating area

$$I_{\mathsf{D}} = f(V_{\mathsf{DS}})$$

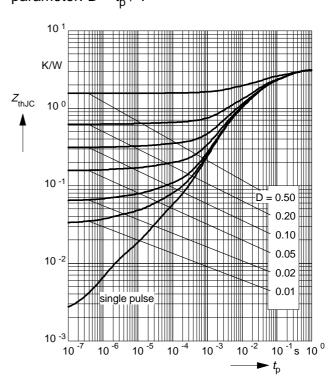
parameter: D = 0.01,  $T_C = 25$ °C



#### **Transient thermal impedance**

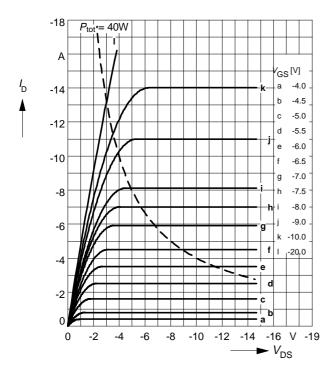
$$Z_{\mathsf{th\ JC}} = f(t_{\mathsf{p}})$$

parameter:  $D = t_p / T$ 



#### Typ. output characteristics

 $I_{\rm D} = f(V_{\rm DS})$  parameter:  $t_{\rm p} = 80~\mu{\rm s}$ 

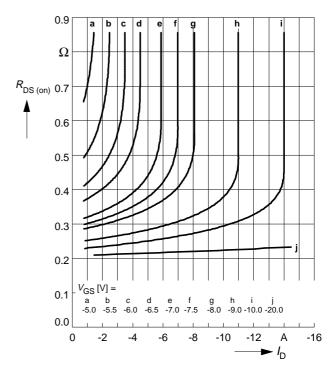


Typ. transfer characteristics  $I_D = f(V_{GS})$  parameter:  $t_p = 80 \mu s$  $V_{DS} \ge 2 \times I_D \times R_{DS(on)max}$ 

-15 -12  $I_{D}$ -11 -10 -9 -8 -7 -6 -5 -4 -3 -2 0 -1 -2 -3 -5 -6 -7 -8 0

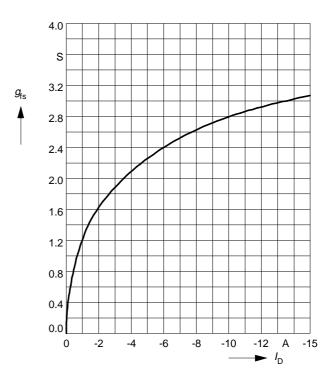
#### Typ. drain-source on-resistance

 $R_{\text{DS (on)}} = f(I_{\text{D}})$  parameter:  $V_{\text{GS}}$ 



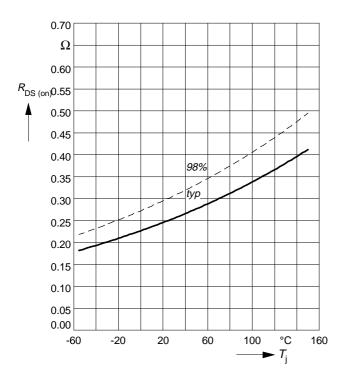
Typ. forward transconductance  $g_{fS} = f(I_D)$ 

parameter:  $t_p = 80 \mu s$ ,  $V_{DS} \ge 2 \times I_D \times R_{DS(on)max}$ 



#### **Drain-source on-resistance**

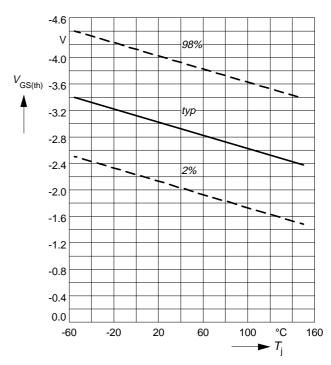
 $R_{\rm DS~(on)} = f(T_{\rm j})$  parameter:  $I_{\rm D} = -5$  A,  $V_{\rm GS} = -10$  V



#### Gate threshold voltage

 $V_{GS (th)} = f(T_j)$ 

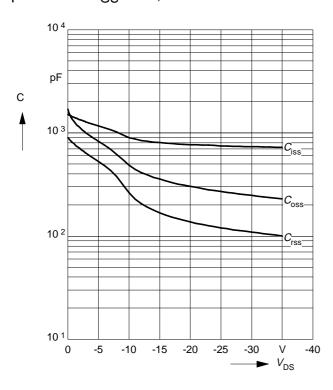
parameter:  $V_{GS} = V_{DS}$ ,  $I_{D} = 1 \text{ mA}$ 



#### Typ. capacitances

 $C = f(V_{DS})$ 

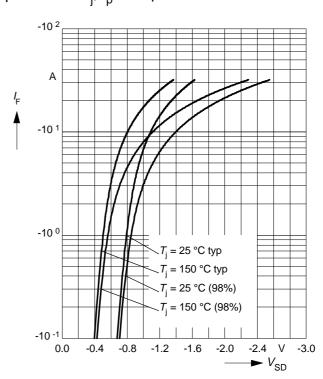
parameter:  $V_{GS} = 0V$ , f = 1MHz



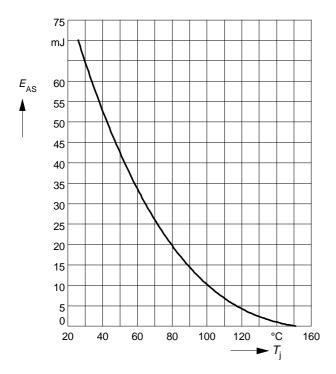
#### Forward characteristics of reverse diode

 $I_{\mathsf{F}} = f(V_{\mathsf{SD}})$ 

parameter:  $T_i$ ,  $t_p = 80 \mu s$ 

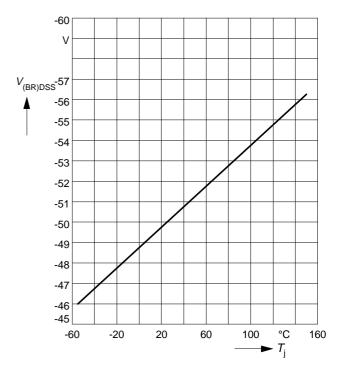


# Avalanche energy $E_{\rm AS} = f(T_{\rm j})$ parameter: $I_{\rm D}$ = -8 A, $V_{\rm DD}$ = -25 V $R_{\rm GS}$ = 25 $\Omega$ , L = 1.1 mH



#### Drain-source breakdown voltage

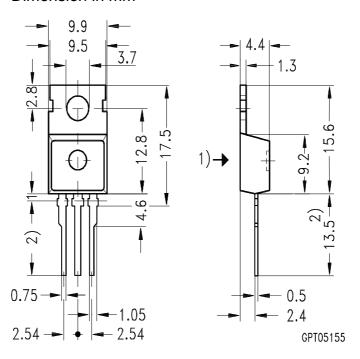
$$V_{(\mathsf{BR})\mathsf{DSS}} = f(T_{\mathsf{j}})$$



#### **Package Outlines**

TO-220 AB

Dimension in mm



- 1) punch direction, burr max. 0.04
- 2) dip tinning
- 3) max. 14.5 by dip tinning press burr max. 0.05